



Registration No. DAT-P-207/05

EMC - TEST REPORT

Test Report No. : E32768-01-00NM	15. July 2008 Date of issue
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Type / Model Name : GENOS DTk 14 SG

Product Description : Digital tachograph

Applicant : LIKA Teknoloji Bilisim Elektronik Sanayi ve Ticaret A.S.

Address : Anadolu Bulcari 2. Cadde

A.T.B. Is Merkezi No. 236 Macunköy

YENIMAHALLE-ANKARA, TÜRKREY

Manufacturer : LIKA Teknoloji Bilisim Elektronik Sanayi ve Ticaret A.S.

Address : Anadolu Bulcari 2. Cadde

A.T.B. Is Merkezi No. 236 Macunköy

YENIMAHALLE-ANKARA, TÜRKREY

Test Result according to the standards listed in clause 1 test standards:	POSITIVE
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The test report merely corresponds to the test sample. It is not permitted to copy extracts of these test results without the written permission of the test laboratory.

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1 TEST STANDARDS

The tests were performed according to following standards:

- | | | |
|-------------------------------------|--------------------|--------|
| <input type="checkbox"/> | EN 13309 | : 2000 |
| <input type="checkbox"/> | EN 1789 | : 1999 |
| <input type="checkbox"/> | EN 50148 | : 1995 |
| <input type="checkbox"/> | EN ISO 14982 | : 1998 |
| <input type="checkbox"/> | EVOBus | : 2000 |
| <input type="checkbox"/> | GMW3097 | : 2006 |
| <input type="checkbox"/> | GMW3100 | : 2001 |
| <input type="checkbox"/> | GS 95002 | : 2004 |
| <input type="checkbox"/> | ISO 13766 | : 2006 |
| <input type="checkbox"/> | JCB 7800/0107 | : 2001 |
| <input type="checkbox"/> | M 3285 | : 2001 |
| <input type="checkbox"/> | MBN 22100-2 | : 2001 |
| <input type="checkbox"/> | TL 965 | : 2006 |
| <input type="checkbox"/> | TL 820 66 | : 2006 |
| <input type="checkbox"/> | TL 821 66 | : 2004 |
| <input checked="" type="checkbox"/> | 72/245/EC | : 1972 |
| <input checked="" type="checkbox"/> | 2004/104/EC | : 2004 |
| <input checked="" type="checkbox"/> | 2006/28/EC | : 2006 |
| <input type="checkbox"/> | 2006/120/EC | : 2006 |
| <input type="checkbox"/> | applicant specific | |
| <input type="checkbox"/> | CISPR 12 | : 2001 |
| <input checked="" type="checkbox"/> | CISPR 25 | : 2002 |
| <input type="checkbox"/> | EN 55025 | : 2003 |
| <input type="checkbox"/> | ISO 11451-1 | : 2005 |
| <input type="checkbox"/> | ISO 11451-2 | : 2005 |
| <input type="checkbox"/> | DIN ISO 11451-3 | : 2000 |
| <input type="checkbox"/> | ISO 11451-4 | : 1995 |
| <input type="checkbox"/> | ISO 11452-1 | : 2005 |
| <input checked="" type="checkbox"/> | ISO 11452-2 | : 2004 |
| <input type="checkbox"/> | ISO 11452-3 | : 2001 |
| <input checked="" type="checkbox"/> | ISO 11452-4 | : 2005 |
| <input type="checkbox"/> | ISO 11452-5 | : 2002 |
| <input type="checkbox"/> | DIN 40839 Part 4 | : 1990 |
| <input type="checkbox"/> | DIN 40839 Part 1 | : 1992 |
| <input type="checkbox"/> | DIN 40839 Part 3 | : 1991 |
| <input checked="" type="checkbox"/> | ISO 7637 Part 2 | : 2004 |
| <input type="checkbox"/> | ISO 7637 Part 3 | : 1999 |
| <input type="checkbox"/> | ISO 10605 | : 2001 |

2 SUMMARY

2.1 General remarks

None

2.2 Summary for all EMC tests

Type of test		Test result	
EMC emission:			
AES	Transient emission test	Fulfilled	
ARE	Radiated emissions – ALSE	Fulfilled	
Immunity:			
APU	Transient immunity test (24V power line)	Fulfilled	A/B/C
ARI	Radiated electromagnetic energy – absorber lined chamber	Fulfilled	A
ARI	Radiated electromagnetic energy – bulk current injection	Fulfilled	A

2.3 Final assessment

Date of receipt of test sample : acc. to storage records

Testing commenced on : 14. July 2008

Testing concluded on : 15. July 2008

Checked by:

Tested by:

Thomas Weise
Dipl.-Ing.(FH)
Laboratory Manager

Nicole Mikes
Dipl.-Ing.(FH)

3 EQUIPMENT UNDER TEST

3.1 Photo documentation of the EuT



3.2 Power supply system utilised

Power supply voltage : 24 V_{DC}

3.3 Short description of the Equipment under Test (EuT)

The Equipment under Test is a digital tachograph for the use in vehicles.

Number of tested samples: 1
Serial number: Test sample 1

EuT operation mode:

The equipment under test was operated during the measurement under the following conditions:

- speed 75 km/h: generated by a function generator

EuT configuration:

(The CDF filled by the applicant can be viewed at the test laboratory.)

The following peripheral devices and interface cables were connected during the measurements:

- Function generator Model : Agilent
 - _____ Model : _____
 - _____ Model : _____
- customer specific cables
- V_{Batt}
 - GND
 - Pulse In

3.4 Performance level

The test results shall be classified in terms of the loss of function or degradation of performance of the equipment under test, relative to a performance level defined by its manufacturer or the requestor of the test, or agreed between the manufacturer and the purchaser of the product.

Definition related to the performance level:

- based on the used product standard
- based on the declaration of the manufacturer, requestor or purchaser

Criterion A:

Definition: normal performance within limits specified by the manufacturer, requestor or purchaser:

All functions of a device/system perform as designed during and after exposure to disturbance. No changes to the speed occurs.

Criterion B:

Definition: temporary loss of function or degradation of performance which ceases after the disturbance ceases, and from which the equipment under test recovers its normal performance, without operator intervention:

All functions of a device/system perform as designed during exposure. However, one or more of them can go beyond specified tolerance. All functions return automatically to within normal limits after exposure is removed. Memory functions shall remain class A. The speed changes minimal, the display may flicker.

Criterion C:

Definition: temporary loss of function or degradation of performance, the correction of which requires operator intervention:

One or more functions of a device/system do not perform as designed during exposure but return automatically to normal operation after exposure is removed. During the test the device switches off, but returns automatically to the selected operation mode after exposure is removed.

Criterion D:

Definition: loss of function or degradation of performance, which is not recoverable, owing to damage to hardware or software, or loss of data:

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4 TEST ENVIRONMENT

4.1 Address of the test laboratory

**mikes-testingpartners gmbh
Ohmstrasse 2-4
94342 Strasskirchen
Germany**

4.2 Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature: 15-35 ° C

Humidity: 30-60 %

Atmospheric pressure: 86-106 kPa

4.3 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16-4-2 /11.2003 „Uncertainties, statistics and limit modelling – Uncertainty in EMC measurements“ and is documented in the quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

5 TEST CONDITIONS AND RESULTS

5.1 Transient emission test

For test instruments and accessories used see section 6 Part AES.

5.1.1 Description of the test location

Test location: AREA 5

5.1.2 Photo documentation of the test set-up



5.1.3 Test result

The requirements are **FULFILLED**.

Remarks: Test date: 15.07.2008, NM

The limits are met.

5.1.4 Test protocol

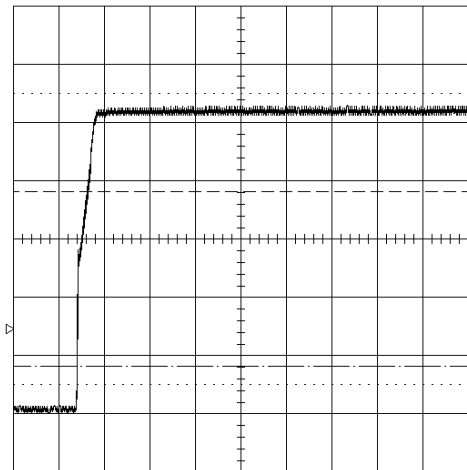
Operation mode: speed 75 km/h
 Remarks: none
 Date: 15.07.2008
 Tested by: Nicole Mikes

Result: passed

Pulse type	Limit [V]	Result [V]
Positive	+ 150	0

15-Jul-08
12:37:22

1 5 ms
5.0 V
15.00 V



5 ms
1 50 mV DC 100

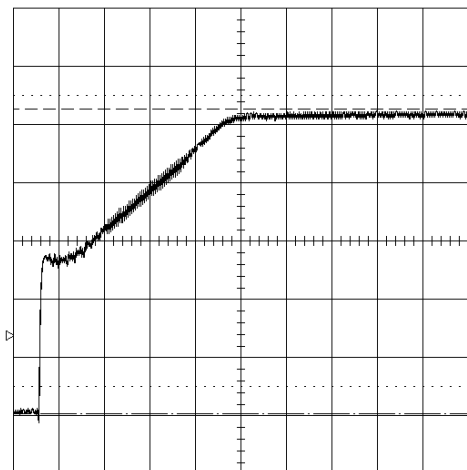
2 .5 V 500 1 DC 7.2 V

200 kS/s

NORMAL

15-Jul-08
12:41:35

1 .5 ms
5.0 V
26.17 V



.5 ms
1 50 mV DC 100

2 .5 V 500 1 DC 6.8 V

2 MS/s

NORMAL

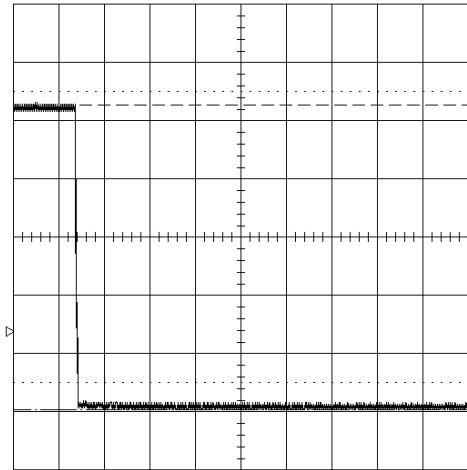
Operation mode: speed 75 km/h
 Remarks: none
 Date: 15.07.2008
 Tested by: Nicole Mikes

Result: passed

Pulse type	Limit [V]	Result [V]
Negative	- 450	0

15-Jul-08
12:38:25

1 5 ms
5.0 V
26.17 V



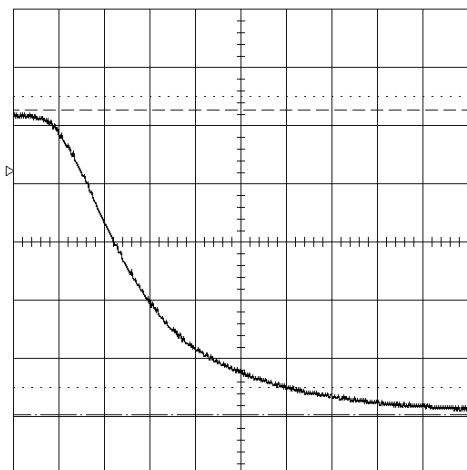
5 ms
1 50 mV DC $\times 100$
2 .5 V 500

1 DC 6.8 V

200 kS/s
SLOW TRIGGER
 NORMAL

15-Jul-08
12:42:34

1 20 μ s
5.0 V
26.17 V



20 μ s
1 50 mV DC $\times 100$
2 .5 V 500

1 DC 21.0 V

50 MS/s
SLOW TRIGGER
 NORMAL

5.2 Transient immunity test (24V power line)

For test instruments and accessories used see section 6 Part APU.

5.2.1 Description of the test location

Test location: AREA 5

5.2.2 Photo documentation of the test set-up



5.2.3 Test specification

Pulse 1: Level: III
 Test level: - 450 V
 Number of pulses: 5000

Pulse 2a: Level: III
 Test level: + 37 V
 Number of pulses: 5000

Pulse 2b: Level: III
 Test level: + 20 V
 Number of pulses: 10

Pulse 3a: Level: III
 Test level: - 150 V
 Coupling duration: 1 h

Pulse 3b: Level: III
 Test level: + 150 V
 Coupling duration: 1 h

Pulse 4: Level: III
 Test level: - 12 V
 Number of pulses: 1

5.2.4 Coupling points

Cable description: DC power line

Screening: screened
 Status: active
 Signal transmission: analogue
 Length: 0.5 m

5.2.5 Test result

	Remarks	Performance Criterion
Pulse 1	During the pulses a short flicker occurs on the display, the speed changes ± 2 km/h. After the test the DUT returns automatically to the selected operation mode.	B
Pulse 2a	No deviation was detected during the test to the selected operation mode.	A
Pulse 2b	During the pulses the device switches off. After the test the DUT returns automatically to the selected operation mode.	C
Pulse 3a	No deviation was detected during the test to the selected operation mode.	A
Pulse 3b	No deviation was detected during the test to the selected operation mode.	A
Pulse 4	No deviation was detected during the test to the selected operation mode.	A

The requirements are **FULFILLED**.

Performance Criterion: **A/B/C**

Remarks: Test date: 15.07.2008, NM

5.3 Radiated emissions – ALSE

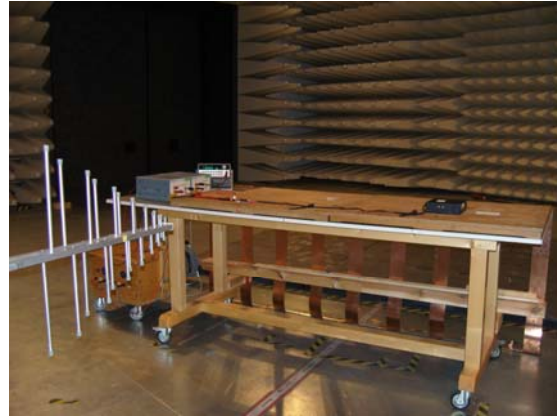
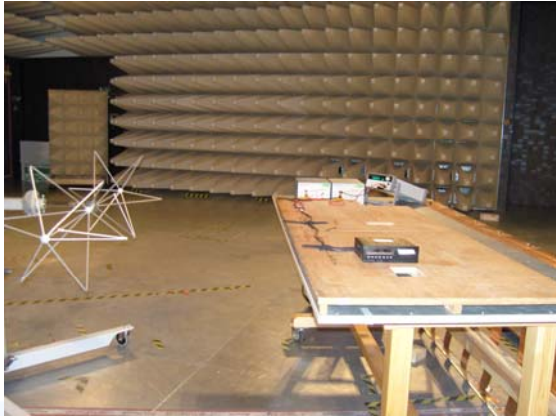
For test instruments and accessories used see section 6 Part **ARE**.

5.3.1 Description of the test location

Test stand: **ARE(A1)** Test location: Anechoic Chamber A1

Test distance: 1 metre

5.3.2 Photo documentation of the test set-up



5.3.3 Test result

Frequency range: 30 MHz - 1000 MHz

Min. limit margin broad band > 5 dB

Min. limit margin narrow band > 5 dB

The requirements are **FULFILLED**.

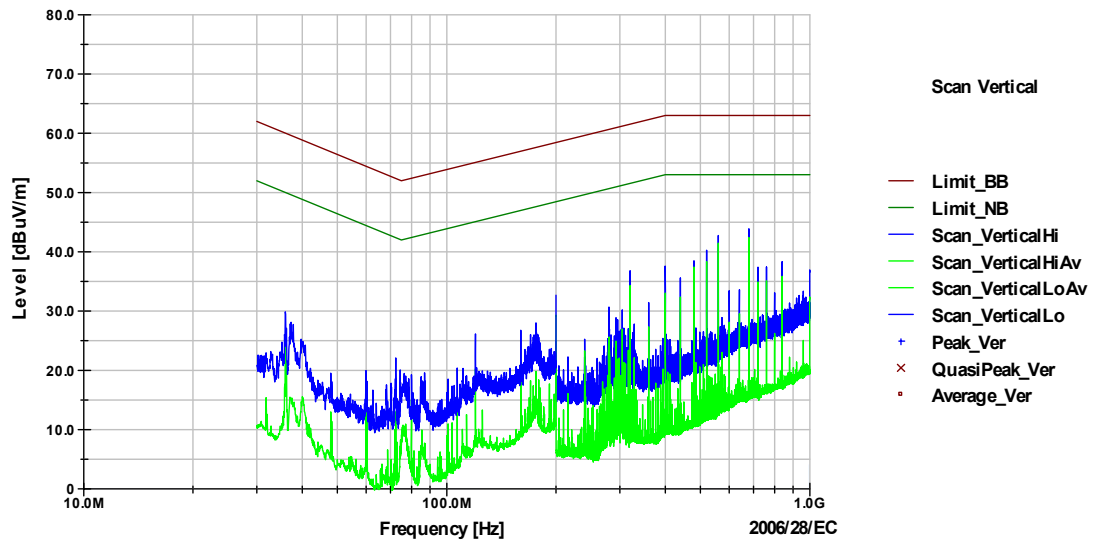
Remarks: Test date: 14.07.2008, WB

The limits are met.

5.3.4 Test protocol

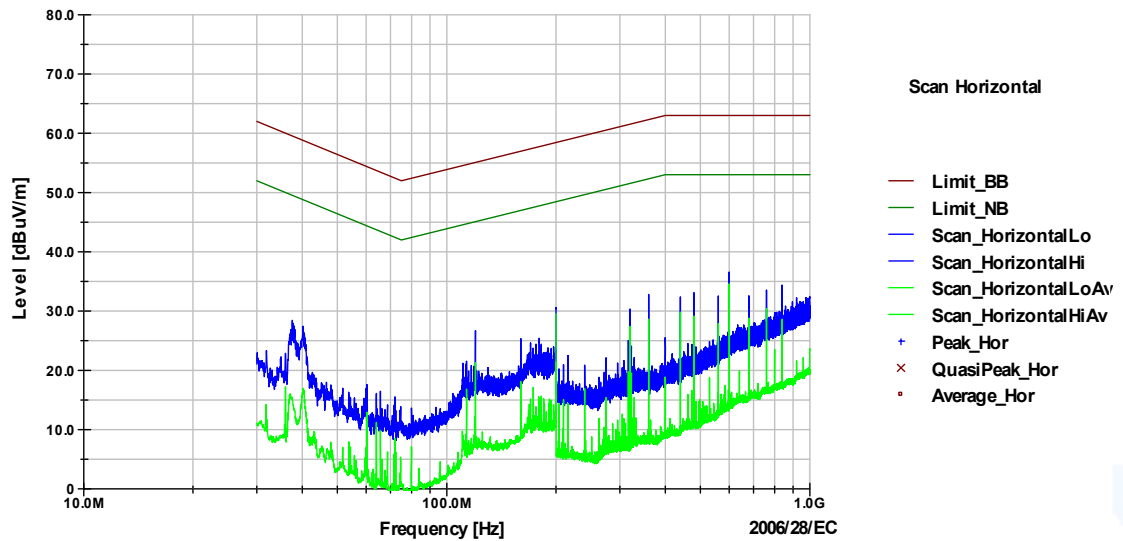
antenna position: front
 antenna polarisation: vertical
 Operation mode: speed 75 km/h
 Remarks: none
 Date: 14.07.2008
 Tested by: Walter G. Bosin

Result: passed



antenna position: front
 antenna polarisation: horizontal
 Operation mode: speed 75 km/h
 Remarks: none
 Date: 14.07.2008
 Tested by: Walter G. Bosin

Result: passed



5.4 Radiated electromagnetic energy – absorber lined chamber

For test instruments and accessories used see section 6 Part ARI.

5.4.1 Description of the test location

Test stand: **ARI(A1)** Test location: Anechoic Chamber A1

5.4.2 Photo documentation of the test set-up



5.4.3 Test specification

<u>Frequency range:</u>	80 – 2000 MHz
<u>Field strength:</u>	30 V/m
<u>EuT - antenna distance:</u>	1 m
<u>Modulation:</u>	AM: 80 % / sinusoidal: 1000Hz (80 – 800 MHz) PM / square wave: 217 Hz / $t_{on} = 577 \mu s$ (800 – 2000 MHz)
<u>Frequency step:</u>	1 MHz from 80 - 200 MHz 2 MHz from 200 - 400 MHz 5 MHz from 400 - 1000 MHz 25 MHz from 1000 – 2000 MHz
<u>Dwell time:</u>	2 sec.
<u>Antenna polarisation:</u>	- vertical

5.4.4 Test result

The requirements are **FULFILLED**.

Performance Criterion: **A**

Remarks: Test date: 14.07.2008, NM

The ESA didn't show any malfunction which would cause any degradation of performance which could cause confusion to other road users or any degradation in the driver's direct control of a vehicle fitted with the ESA.

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5.5 Radiated electromagnetic energy – bulk current injection

For test instruments and accessories used see section 6 Part ARI.

5.5.1 Description of the test location

Test location: Anechoic Chamber A1

5.5.2 Photo documentation of the test set-up



5.5.3 Test specification

<u>Frequency range:</u>	20 – 80 MHz
<u>Current:</u>	60 mA
<u>Modulation:</u>	AM: 80 % / sinusoidal: 1000Hz
<u>Frequency step:</u>	1 MHz from 20 - 80 MHz
<u>Dwell time:</u>	2 sec.

5.5.4 Coupling points

Cable description:	<u>Cable harness</u>
Screening:	unscreened/screened
Status:	active
Signal transmission:	analogue/digital
Length:	1 m

5.5.5 Test result

The requirements are **FULFILLED**.

Performance Criterion: **A**

Remarks: Test date: 14.07.2008, NM

The ESA didn't show any malfunction which would cause any degradation of performance which could cause confusion to other road users or any degradation in the driver's direct control of a vehicle fitted with the ESA.

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6 USED TEST EQUIPMENT AND ACCESSORIES

All test instruments used, in addition to the test accessories, are calibrated and verified regularly.

Test ID	Model / Type	Kind of Equipment	Manufacturer	Equipment No.
AES	9350	Storage Oscilloscope	LeCroy Europe GmbH	02-02/13-05-002
	NNB-5 μ H / 100 A-115 V	LISN	SBF electronic	02-02/20-05-006
	100x	Tastkopf Oscilloscope	Conrad Electronic GmbH	02-02/50-05-239
	ES35/300V3S	Electronic Switch	SBF electronic	02-02/50-07-027
	10 Ohm 100 W	Widerstandsbox / AES	mikes-testingpartners gmbh	02-02/50-08-004
APU	FG5620	Function Generator	WEETECH GmbH	02-02/05-07-002
	TC5650	Transf. Conducted Coupler	WEETECH GmbH	02-02/05-07-003
	FT 5530	Burst Generator	WEETECH GmbH	02-02/09-07-001
	LD 5505	Load Dump Generator	WEETECH GmbH	02-02/09-07-002
	MT5511	Micro Transient Generator	WEETECH GmbH	02-02/09-07-003
	PA 5640	Power Amplifier	WEETECH GmbH	02-02/17-07-002
	DS5630	DC Switch	WEETECH GmbH	02-02/50-07-020
ARE	ESCI	EMI Test Receiver	Rohde & Schwarz München	02-02/03-05-004
	NNB-5 μ H / 100 A-115 V	LISN	SBF electronic	02-02/20-05-006
	NNB-5 μ H / 100 A-115 V	LISN	SBF electronic	02-02/20-05-008
	BBA 9106 / VHA 9103	Biconical Antenna	Schwarzbeck Mess-Elektronik	02-02/24-05-001
	VULB 9165	Trilog-Broadband Antenna	Schwarzbeck Mess-Elektronik	02-02/24-05-017
	N-11000-NW	RF Cable	mikes-testingpartners gmbh	02-02/50-05-188
	N-3000-N	RF Cable	mikes-testingpartners gmbh	02-02/50-05-192
	Sucofeed 1/2	RF Cable	Huber + Suhner	02-02/50-06-033
	Automotive Ground Plane	Automotive Ground Plane	mikes-testingpartners gmbh	02-02/50-06-049
	ARI	SME 03	Signal Generator	Rohde & Schwarz München
NRVD		Dual Channel Power Meter	Rohde & Schwarz München	02-02/07-05-019
URV 5 - Z 2		RF Probe 10 V	Rohde & Schwarz München	02-02/07-05-021
URV 5 - Z 2		RF Probe 10 V	Rohde & Schwarz München	02-02/07-05-022
1000W1000C		RF Amplifier	Amplifier Research	02-02/17-05-011
500A100A		RF Amplifier	Amplifier Research	02-02/17-05-012
100S1G4		RF Amplifier	Amplifier Research	02-02/17-05-018
NNB-5 μ H / 100 A-115 V		LISN	SBF electronic	02-02/20-05-006
NNB-5 μ H / 100 A-115 V		LISN	SBF electronic	02-02/20-05-008
F-120-9		RF Clamp	FCC Fischer Custom Comm.	02-02/22-05-014
AT 5080		Log. Per. Antenna	Amplifier Research	02-02/24-05-024
CTR-1001A		RadiSense/E-Field Sensor	DARE	02-02/50-05-034
DC62080AM1		Coupler	Amplifier Research	02-02/50-05-101
7/16-1500-7/16		RF Cable	mikes-testingpartners gmbh	02-02/50-05-102
50 Ohm / 10 dB		Attenuator	Huber + Suhner	02-02/50-05-106
7/16-6000-7/16		RF Cable	Rosenberger HF-Technik	02-02/50-05-109
DC7144A		Coupler	Amplifier Research	02-02/50-05-158
DC2600A		Coupler	Amplifier Research	02-02/50-05-159
NW-2000-NW		RF Cable	mikes-testingpartners gmbh	02-02/50-05-193
N-2000-N		RF Cable	mikes-testingpartners gmbh	02-02/50-06-045
N-2000-N		RF Cable	mikes-testingpartners gmbh	02-02/50-06-046
Automotive Ground Plane		Automotive Ground Plane	mikes-testingpartners gmbh	02-02/50-06-049
Relaismatrix		Relaismatrix	mikes-testingpartners gmbh	02-02/50-06-050
NW-5000-NW	RF Cable	mikes-testingpartners gmbh	02-02/50-07-024	
NW-2000-NW	RF Cable	mikes-testingpartners gmbh	02-02/50-07-025	
NW-3500-NW	RF Cable	mikes-testingpartners gmbh	02-02/50-07-026	